

Search Notes



Application No.

10/625,691

Examiner

Linh V Nguyen

Applicant(s)

OHASHI ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	118		
	120		
	143		
	144		
375	142		
	148		
	238		
	295		
	298		
	324		
	348		
	350	9/29/04	L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
341	143	9/29/04	L
341	144	9/29/04	L

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
low pass, cut off frequency, filter first, second	9/29/04	L
Sigma, digital -analog,	9/29/04	L